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				Filing Date	Herewith
				First Named Inventor	Otomo et al.
				Art Unit	Not Yet Assigned 2816
				Examiner Name	Not Yet Assigned Khareem Almo
Sheet	1	of	1	Attorney Docket	85366

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ²			
KA		US-6,225,831 B1	05/01/2001	Dalmia et al.	
KA		US-6,421,404 B1	07/16/2002	Nakamura	
KA		US-2003/0142774 A1	07/31/2003	Takasoh et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³ -Number ⁴ -Kind Code ⁵			
KA		JP2000077990	03/14/2000	Victor Co. of Japan Ltd.	X
KA		JP2001144592	05/25/2001	Fujitsu Ltd.	X
KA		JP2002171160	06/14/2002	Nec Eng Ltd.	X

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
KA		NAKAMURA, KAZUYUKI; FUKAISHI, MUNEO; ABIKO, HITOSHI; MATSUMOTO, AKIRA and YOTSUYANAGI, MICHIO, A 6 Gbps CMOS Phase Detecting DEMUX Module Using Half-Frequency Clock, IEEE, 1998			
KA		SAVOJ, JAFAR and RAZAVI, BEHZAD, A 10-Gb/s CMOS Clock and Data Recovery Circuit with a Half-Rate Linear Phase Detector, IEEE Journal of Solid-State Circuits, Vol. 36, No. 5, May 2001, pages 761-768.			
KA		OHTOMO, YUSUKE; KAWAMURA, TOMOAKI; NISHIMURA, KAZUYOSHI, NOGAWA, MASAFUMI; KOIZUMI, HIROSHI and TOGASHI, MINOURU, A 12.5 Gb/s CMOS BER Test Using A Jitter-Tolerant Parallel CDR, IEEE International Solid-State Circuits Conference, ISSCC Digest of Technical Papers, Feb. 2004, pages 174-175.			

Examiner Signature	/Khareem Almo/	Date Considered	07/20/2006
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